

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/550,436	OBINATA ET AI	<u>L.</u>
Examiner	Art Unit	
ANOOP SINGH	1632	

	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST: USPAT, US-PGPUB, EPO, JPO, DERWENT Search report Seperately attached	2/5/2008	AKS	
STN, Embase, Medline, Caplus, BiosisSearch report Seperately attached	2/5/2008	AKS	
PALMInventor Name Search	2/5/2008	AKS	